UNIVERSITY OF CALIFORNIA College of Engineering Department of Electrical Engineering and Computer Sciences

EE 130/230A Fall 2013

Prof. Liu

Homework Assignment #13

Due at the beginning of class on Tuesday, 11/26/13

<u>Problem 1</u>: Advanced MOSFET structures

- (a) Why are thin-body MOSFET structures advantageous for channel-length (*L*) scaling as well as supply-voltage (V_{DD}) scaling? (<u>Hint</u>: Note that the drain-to-body pn junction capacitance is significantly reduced.)
- (b) The thin-body MOSFET structure ($T_{Si} < 10 \text{ nm}$) is often referred to as a "fully depleted" MOSFET. Why is this the case? (<u>Hint</u>: The dopant concentration in the body region typically is less than 10^{18} cm^{-3} .)
- (c) What is the primary advantage of a multiple-gate (double-gate or tri-gate) thin-body MOSFET structure over a single-gate thin-body MOSFET structure?

Problem 2: Qualitative BJT Questions

- (a) Draw the energy-band diagrams for a Si NPN BJT in forward-active and saturation modes of operation.
- (b) Draw a family of common-emitter output characteristics ($I_C vs. V_{CE}$ curves for different values of V_{BE}). On your plot, indicate the saturation region and forward active region.
- (c) Suppose the minority-carrier lifetime in the base were drastically reduced somehow. How would the following device parameters be affected, and why?
 - i. transport factor $\alpha_{\rm T}$
 - ii. emitter efficiency γ
 - iii. common-emitter dc current gain β_{dc}